

FORM HDP-1449 (Based on Form PTO-1449)

## PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

Sheet 1 of 1

ATTORNEY DOCKET No.	SERIAL NO.		
9319G-000679	79 10/774,362		
APPLICANT			
Yoshihide Matsuo			
FILING DATE	GROUP		
February 6, 2004	2815		

U.S. P	U.S. PATENT DOCUMENTS							
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date		
1.	>>>							

FORE	FOREIGN PATENT DOCUMENTS							
Ref. Examiner's Document Date Country Class/ Translation *  Desig. Initials Number Date Country Subclass Yes No								
1.		2004-200547	7/15/2004	Japan		Abstract		

OTHE	R DOCUME	ENTS (including Author, Title, Date, Pertinent Pages, etc.)
Ref. Desig.	Examiner's Initials	
1.		

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Examiner: Date Considered: 03-03-05

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Sheet 1 of 1

ATTORNEY DOCKET No.	SERIAL NO.
9319G-000679	to be assigned
APPLICANT	
Yoshihide MATSUO	
FILING DATE	GROUP
Herewith	To be assigned

U.S. PATENT DOCUMENTS							
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date	
1.	acs	5,501,893	3/26/1996	Laermer et al			

FOREIGN PATENT DOCUMENTS								
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	No	
1.	as	2001-044197	2/16/2001	Japan		Abstract		
2.	ass	2002-093776	3/29/2002	Japan		Abstract		

OTHE	R DOCUME	NTS (inc	luding A	luthor, Titl	e, Date, Pe	ertinent Pa	ges, etc	;.)		
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Examiner India

Date Considered:

0-3-03-05

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